



RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for CDMA and multicarrier GSM base station applications with frequencies from 860 to 960 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ} = 2400$ mA, $P_{out} = 100$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

| Frequency | G_{ps} (dB) | η_D (%) | Output PAR (dB) | ACPR (dBc) |
|-----------|---------------|--------------|-----------------|------------|
| 920 MHz | 19.6 | 35.4 | 6.0 | -37.3 |
| 940 MHz | 19.6 | 35.6 | 6.0 | -37.1 |
| 960 MHz | 19.4 | 35.8 | 5.9 | -36.7 |

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 940 MHz, 425 Watts CW Output Power (3 dB Input Overdrive from Rated P_{out}), Designed for Enhanced Ruggedness
- Typical P_{out} @ 1 dB Compression Point ≈ 326 Watts CW

Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- Optimized for Doherty Applications
- RoHS Compliant
- In Tape and Reel. R6 Suffix = 150 Units per 56 mm, 13 inch Reel.

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--------------------------------------|-----------|-------------|------|
| Drain-Source Voltage | V_{DSS} | -0.5, +70 | Vdc |
| Gate-Source Voltage | V_{GS} | -6.0, +10 | Vdc |
| Operating Voltage | V_{DD} | 32, +0 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +150 | °C |
| Case Operating Temperature | T_C | 150 | °C |
| Operating Junction Temperature (1,2) | T_J | 225 | °C |

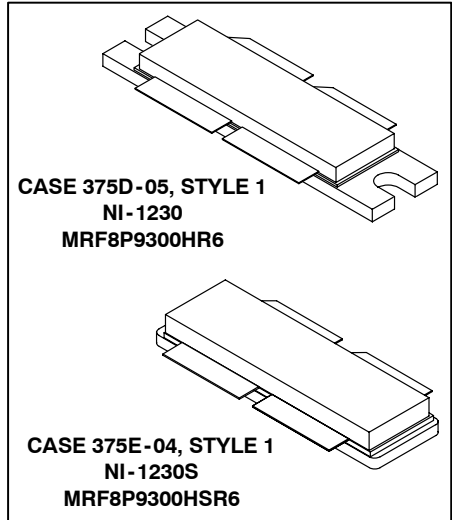
Table 2. Thermal Characteristics

| Characteristic | Symbol | Value (2,3) | Unit |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|--------------|------|
| Thermal Resistance, Junction to Case Case Temperature 75°C, 100 W CW, 28 Vdc, $I_{DQ} = 2400$ mA Case Temperature 80°C, 300 W CW, 28 Vdc, $I_{DQ} = 2400$ mA | $R_{\theta JC}$ | 0.22 0.20 | °C/W |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

MRF8P9300HR6
MRF8P9300HSR6

920-960 MHz, 100 W AVG., 28 V
SINGLE W-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs



CASE 375D-05, STYLE 1
NI-1230
MRF8P9300HR6

CASE 375E-04, STYLE 1
NI-1230S
MRF8P9300HSR6

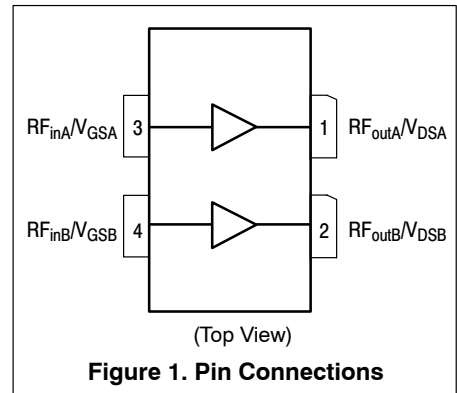


Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|--------------|
| Human Body Model (per JESD22-A114) | 1C (Minimum) |
| Machine Model (per EIA/JESD22-A115) | A (Minimum) |
| Charge Device Model (per JESD22-C101) | IV (Minimum) |

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---------------------------------------------------------------------------------------------------|-----------|-----|-----|-----|-----------------|
| Off Characteristics ⁽¹⁾ | | | | | |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 70\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) | I_{DSS} | — | — | 10 | μAdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) | I_{DSS} | — | — | 1 | μAdc |
| Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$) | I_{GSS} | — | — | 1 | μAdc |

On Characteristics

| | | | | | |
|-----------------------------------------------------------------------------------------------------------------|--------------|-----|-----|-----|-----|
| Gate Threshold Voltage ⁽¹⁾ ($V_{DS} = 10\text{ Vdc}$, $I_D = 400\ \mu\text{Adc}$) | $V_{GS(th)}$ | 1.5 | 2.3 | 3 | Vdc |
| Gate Quiescent Voltage ($V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 2400\text{ mA}$, Measured in Functional Test) | $V_{GS(Q)}$ | 2.3 | 3.1 | 3.8 | Vdc |
| Drain-Source On-Voltage ⁽¹⁾ ($V_{GS} = 10\text{ Vdc}$, $I_D = 3\text{ Adc}$) | $V_{DS(on)}$ | 0.1 | 0.2 | 0.3 | Vdc |

Functional Tests ⁽²⁾ (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 2400\text{ mA}$, $P_{out} = 100\text{ W Avg.}$, $f = 960\text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.

| | | | | | |
|----------------------------------------------------------|----------|------|-------|-------|-----|
| Power Gain | G_{ps} | 18.0 | 19.4 | 21.0 | dB |
| Drain Efficiency | η_D | 32.0 | 35.8 | — | % |
| Output Peak-to-Average Ratio @ 0.01% Probability on CCDF | PAR | 5.6 | 5.9 | — | dB |
| Adjacent Channel Power Ratio | ACPR | — | -36.7 | -34.0 | dBc |
| Input Return Loss | IRL | — | -16 | -10 | dB |

Typical Broadband Performance (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 2400\text{ mA}$, $P_{out} = 100\text{ W Avg.}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.

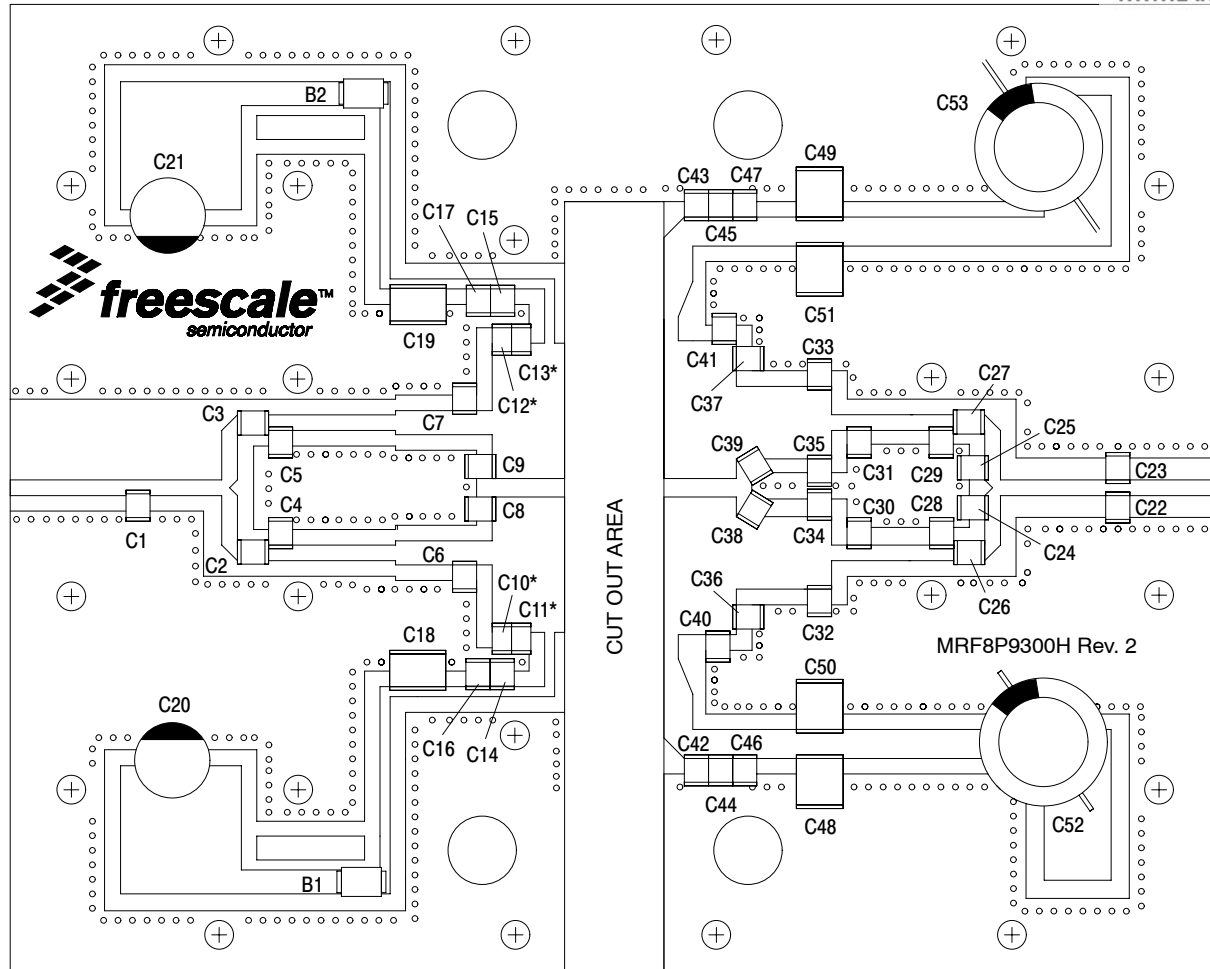
| Frequency | G_{ps} (dB) | η_D (%) | Output PAR (dB) | ACPR (dBc) | IRL (dB) |
|-----------|------------------|-----------------|--------------------|---------------|-------------|
| 920 MHz | 19.6 | 35.4 | 6.0 | -37.3 | -9 |
| 940 MHz | 19.6 | 35.6 | 6.0 | -37.1 | -12 |
| 960 MHz | 19.4 | 35.8 | 5.9 | -36.7 | -16 |

- Each side of device measured separately.
- Part internally matched both on input and output.

(continued)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|-----|-------|-----|-----------------------|
| Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 2400\text{ mA}$, 920-960 MHz Bandwidth | | | | | |
| P_{out} @ 1 dB Compression Point, CW | P_{1dB} | — | 326 | — | W |
| IMD Symmetry @ 310 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2\text{ dB}$) | IMD_{sym} | — | 17 | — | MHz |
| VBW Resonance Point (IMD Third Order Intermodulation Inflection Point) | VBW_{res} | — | 30 | — | MHz |
| Gain Flatness in 40 MHz Bandwidth @ $P_{out} = 100\text{ W Avg.}$ | G_F | — | 0.16 | — | dB |
| Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$) | ΔG | — | 0.012 | — | dB/ $^\circ\text{C}$ |
| Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$) | ΔP_{1dB} | — | 0.008 | — | dBm/ $^\circ\text{C}$ |



*C10, C11, C12, and C13 are mounted vertically.

Figure 2. MRF8P9300HR6(HSR6) Test Circuit Component Layout

Table 5. MRF8P9300HR6(HSR6) Test Circuit Component Designations and Values

| Part | Description | Part Number | Manufacturer |
|--------------------------------------|-------------------------------------------|----------------------|--------------------|
| B1, B2 | Short RF Bead | 2743019447 | Fair-Rite |
| C1 | 0.2 pF Chip Capacitor | ATC100B0R2BT500XT | ATC |
| C2, C3, C16, C17, C26, C27 | 39 pF Chip Capacitors | ATC100B390JT500XT | ATC |
| C4, C5, C28, C29, C32, C33, C34, C35 | 1.1 pF Chip Capacitors | ATC100B1R1BT500XT | ATC |
| C6, C7 | 2.7 pF Chip Capacitors | ATC100B2R7BT500XT | ATC |
| C8, C9 | 5.1 pF Chip Capacitors | ATC100B5R1CT500XT | ATC |
| C10, C11, C12, C13 | 3.0 pF Chip Capacitors | ATC100B3R0CT500XT | ATC |
| C14, C15, C42, C43 | 10 pF Chip Capacitors | ATC100B100JT500XT | ATC |
| C18, C19 | 2.2 μ F, 50 V Chip Capacitors | C1825C225J5RAC-TU | Kemet |
| C20, C21 | 47 μ F, 50 V Electrolytic Capacitors | 476KXM050M | Illinois Capacitor |
| C22, C23 | 1.0 pF Chip Capacitors | ATC100B1R0BT500XT | ATC |
| C24, C25 | 0.5 pF Chip Capacitors | ATC100B0R5BT500XT | ATC |
| C30, C31 | 0.8 pF Chip Capacitors | ATC100B0R8BT500XT | ATC |
| C36, C37 | 4.7 pF Chip Capacitors | ATC100B4R7CT500XT | ATC |
| C38, C39 | 4.3 pF Chip Capacitors | ATC100B4R3CT500XT | ATC |
| C40, C41 | 11 pF Chip Capacitors | ATC100B110JT500XT | ATC |
| C44, C45 | 20 pF Chip Capacitors | ATC100B200JT500XT | ATC |
| C46, C47 | 30 pF Chip Capacitors | ATC100B300JT500XT | ATC |
| C48, C49, C50, C51 | 10 μ F, 50 V Chip Capacitors | GRM55DR61H106KA88L | Murata |
| C52, C53 | 470 μ F, 63 V Electrolytic Capacitors | MCGPR63V477M13X26-RH | Multicomp |
| PCB | 0.030", $\epsilon_r = 3.50$ | RF-35 | Taconic |

MRF8P9300HR6 MRF8P9300HSR6

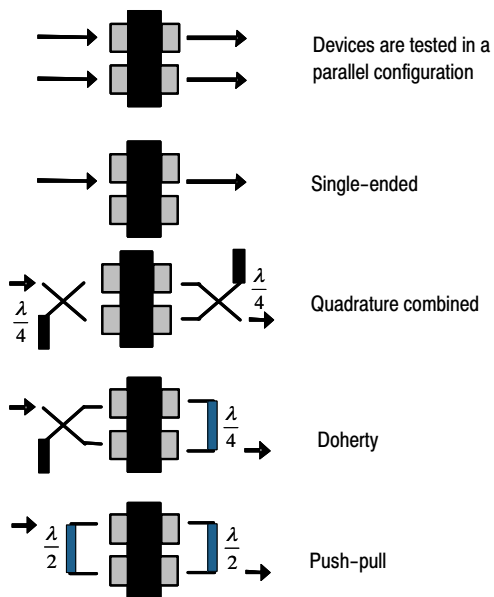


Figure 3. Possible Circuit Topologies

TYPICAL CHARACTERISTICS

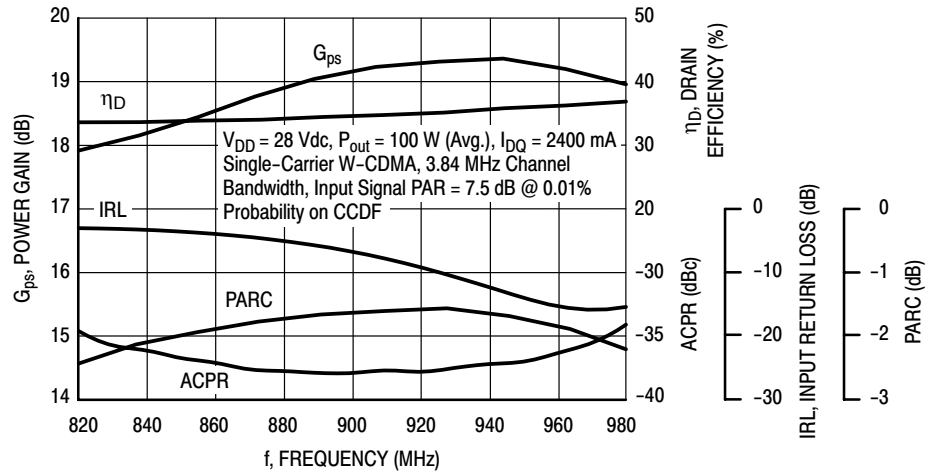


Figure 4. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P_{out} = 100 Watts Avg.

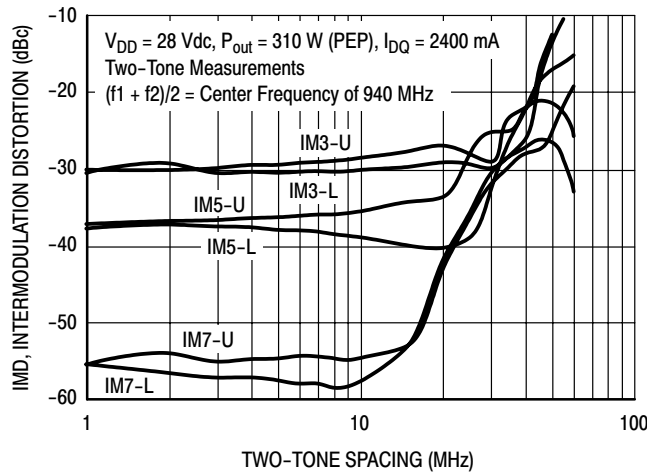


Figure 5. Intermodulation Distortion Products versus Two-Tone Spacing

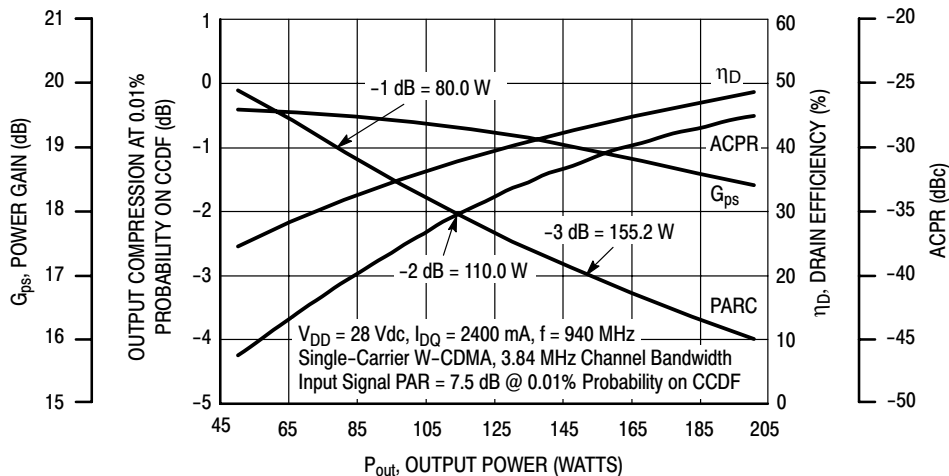


Figure 6. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

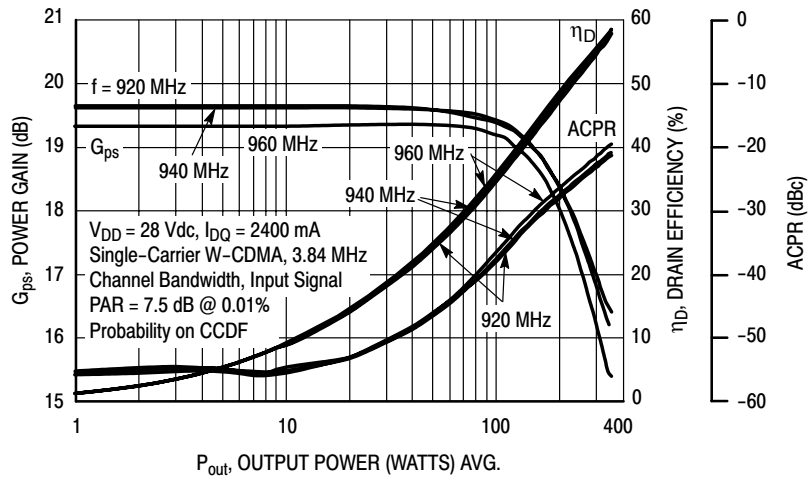


Figure 7. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

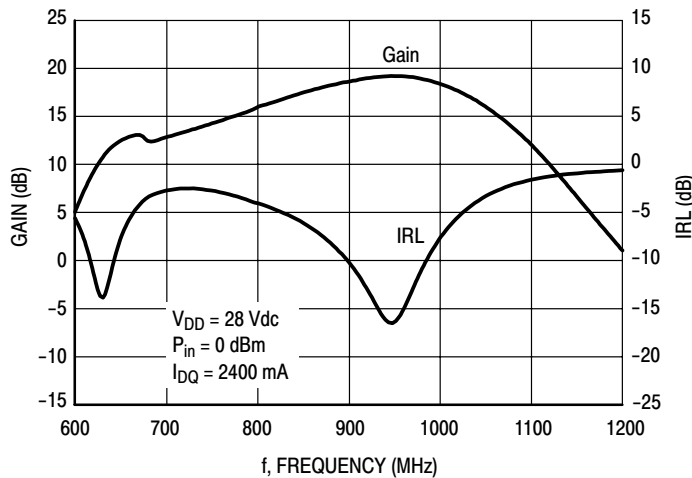


Figure 8. Broadband Frequency Response

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W-CDMA TEST SIGNAL

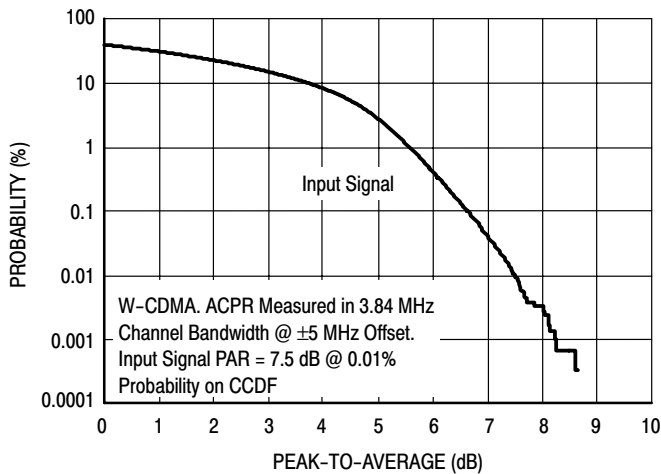


Figure 9. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

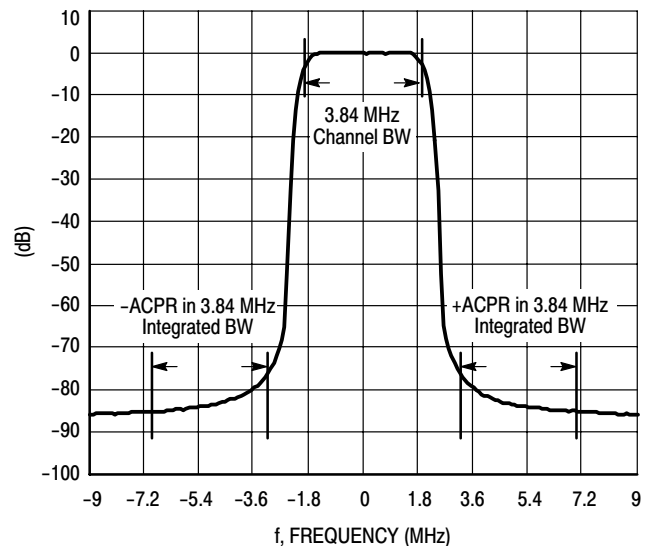


Figure 10. Single-Carrier W-CDMA Spectrum

MRF8P9300HR6 MRF8P9300HSR6

$V_{DD} = 28 \text{ Vdc}$, $I_{DQA} = I_{DQB} = 1200 \text{ mA}$, $P_{out} = 100 \text{ W Avg.}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|----------|--------------------------|------------------------|
| 840 | 1.74 - j1.71 | 0.98 - j0.97 |
| 860 | 1.74 - j1.42 | 0.95 - j0.95 |
| 880 | 1.59 - j1.19 | 0.92 - j0.92 |
| 900 | 1.46 - j0.91 | 0.90 - j0.90 |
| 920 | 1.51 - j0.63 | 0.87 - j0.87 |

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

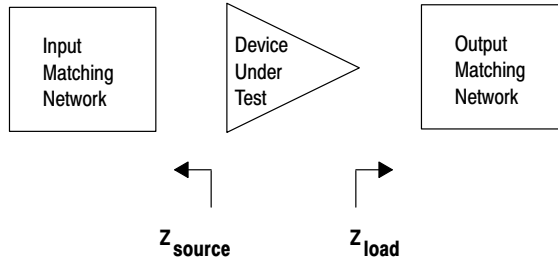
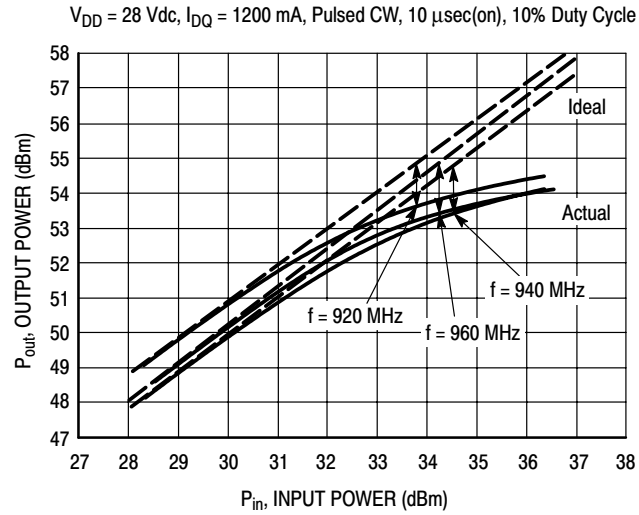


Figure 11. Series Equivalent Source and Load Impedance

ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

| f (MHz) | P1dB | |
|------------|-------|------|
| | Watts | dBm |
| 920 | 229 | 53.6 |
| 940 | 214 | 53.3 |
| 960 | 219 | 53.4 |

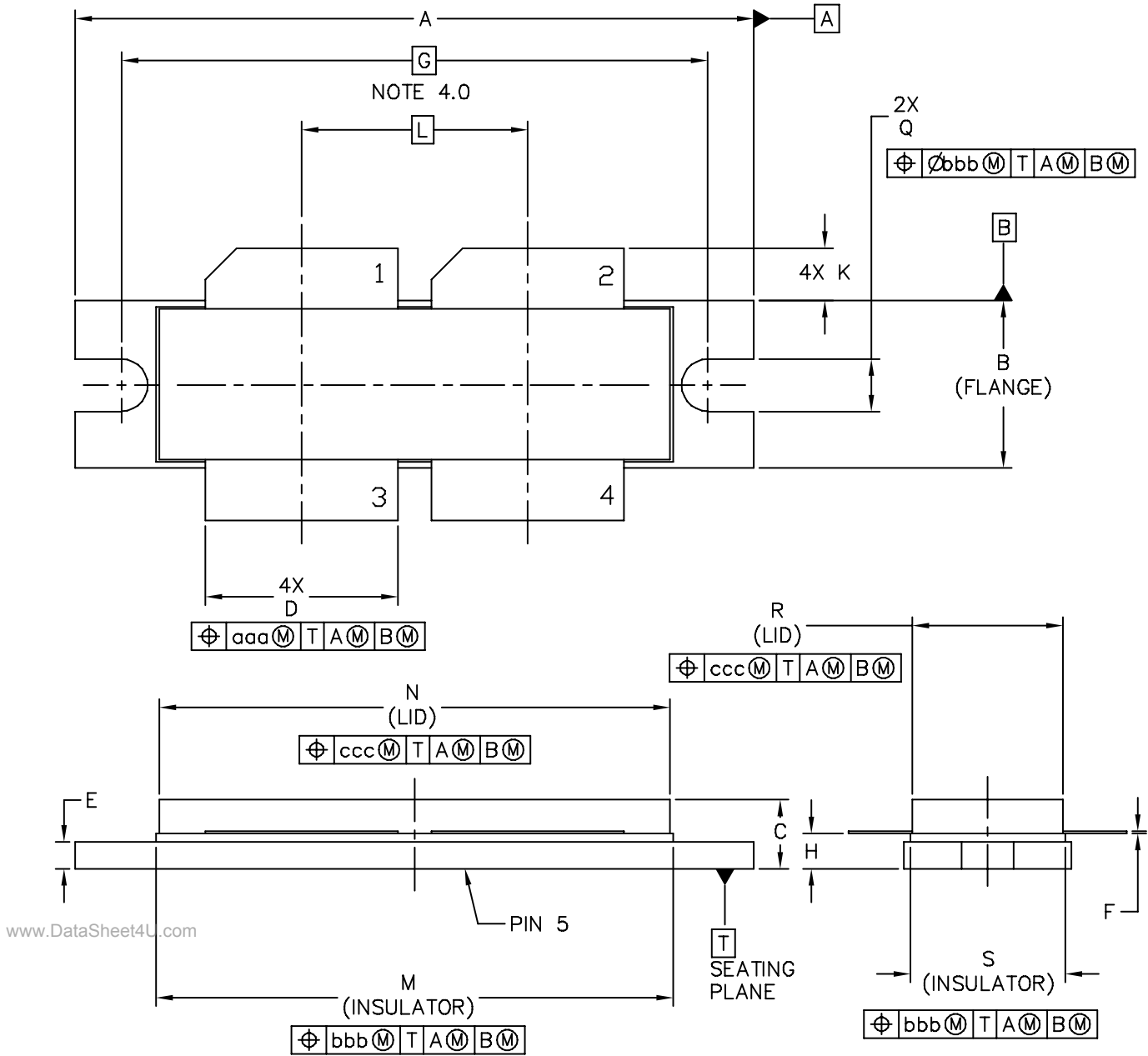
Test Impedances per Compression Level

| f (MHz) | | Z_{source} Ω | Z_{load} Ω |
|------------|------|---------------------------------|-------------------------------|
| 920 | P1dB | $1.58 - j2.40$ | $0.84 - j1.69$ |
| 940 | P1dB | $1.77 - j3.02$ | $0.76 - j1.90$ |
| 960 | P1dB | $1.98 - j3.46$ | $0.75 - j1.51$ |

Figure 12. Pulsed CW Output Power
versus Input Power @ 28 V

NOTE: Measurement made on a per side basis.

PACKAGE DIMENSIONS



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NOTES:

- 1.0 INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2.0 CONTROLLING DIMENSION: INCH
- 3.0 DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.
- 4.0 RECOMMENDED BOLT CENTER DIMENSION OF 1.52 (38.61) BASED ON M3 SCREW.

STYLE 1:

- PIN 1 - DRAIN
 2 - DRAIN
 3 - GATE
 4 - GATE
 5 - SOURCE

| DIM | INCH | | MILLIMETER | | DIM | INCH | | MILLIMETER | |
|-----|-----------|-------|------------|-------|-----|-------|-------|------------|-------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| A | 1.615 | 1.625 | 41.02 | 41.28 | N | 1.218 | 1.242 | 30.94 | 31.55 |
| B | .395 | .405 | 10.03 | 10.29 | Q | .120 | .130 | 3.05 | 3.3 |
| C | .150 | .200 | 3.81 | 5.08 | R | .355 | .365 | 9.01 | 9.27 |
| D | .455 | .465 | 11.56 | 11.81 | S | .365 | .375 | 9.27 | 9.53 |
| E | .062 | .066 | 1.57 | 1.68 | | | | | |
| F | .004 | .007 | 0.1 | 0.18 | | | | | |
| G | 1.400 BSC | | 35.56 BSC | | aaa | .013 | | 0.33 | |
| H | .082 | .090 | 2.08 | 2.29 | bbb | .010 | | 0.25 | |
| K | .117 | .137 | 2.97 | 3.48 | ccc | .020 | | 0.51 | |
| L | .540 BSC | | 13.72 BSC | | | | | | |
| M | 1.219 | 1.241 | 30.96 | 31.52 | | | | | |

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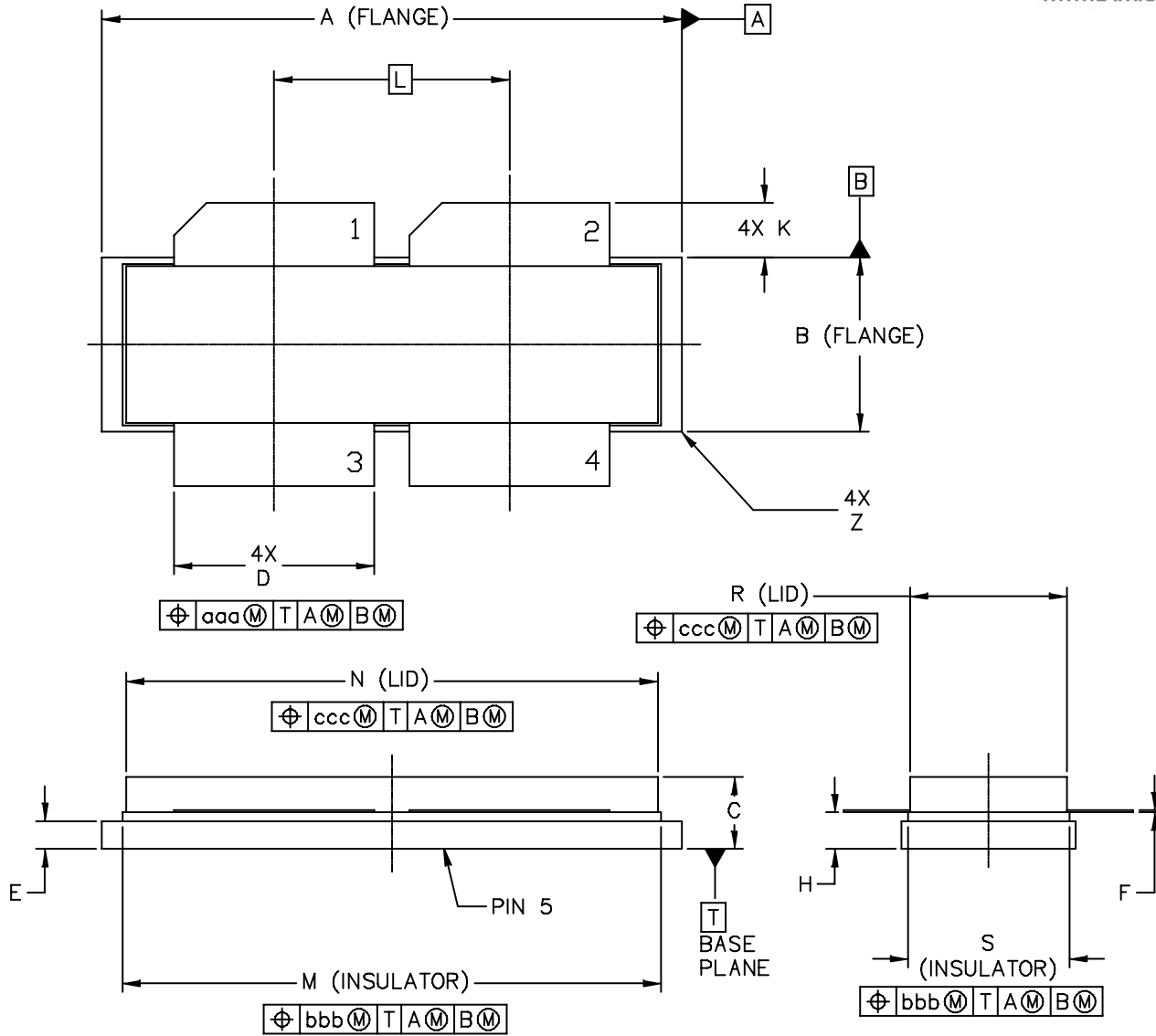
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NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 AWAY FROM PACKAGE BODY

STYLE 1:

- PIN 1 - DRAIN
 2 - DRAIN
 3 - GATE
 4 - GATE
 5 - SOURCE

| DIM | INCHES | | MILLIMETERS | | DIM | INCHES | | MILLIMETERS | |
|---------------------------------------------------------|----------|-------|--------------------|-------|--------------------------|----------------------------|------|-------------|------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| A | 1.265 | 1.275 | 32.13 | 32.38 | R | .355 | .365 | 9.01 | 9.27 |
| B | .395 | .405 | 10.03 | 10.29 | S | .365 | .375 | 9.27 | 9.53 |
| C | .150 | .200 | 3.81 | 5.08 | Z | --- | .040 | --- | 1.02 |
| D | .455 | .465 | 11.56 | 11.81 | | | | | |
| E | .062 | .066 | 1.57 | 1.68 | aaa | .013 | | 0.33 | |
| F | .004 | .007 | 0.1 | 0.18 | bbb | .010 | | 0.25 | |
| H | .082 | .090 | 2.08 | 2.29 | ccc | .020 | | 0.51 | |
| K | .117 | .137 | 2.97 | 3.48 | | | | | |
| L | .540 BSC | | 13.72 BSC | | | | | | |
| M | 1.219 | 1.241 | 30.96 | 31.52 | | | | | |
| N | 1.218 | 1.242 | 30.94 | 31.55 | | | | | |
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| | | | | | STANDARD: NON-JEDEC | | | | |

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|-----------|-----------------------------------------------------------------------------------|
| 0 | Nov. 2009 | <ul style="list-style-type: none"> • Initial Release of Data Sheet |

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